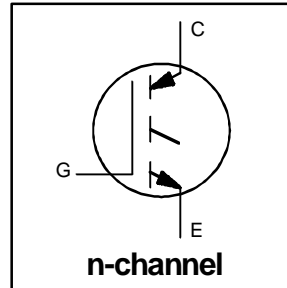


**Features**

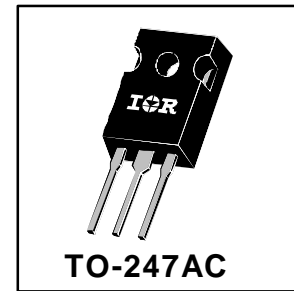
- Switching-loss rating includes all "tail" losses
- Optimized for medium operating frequency (1 to 10kHz) See Fig. 1 for Current vs. Frequency curve



$V_{CES} = 900V$
$V_{CE(sat)} \leq 2.7V$
@ $V_{GE} = 15V, I_C = 28A$

**Description**

Insulated Gate Bipolar Transistors (IGBTs) from International Rectifier have higher usable current densities than comparable bipolar transistors, while at the same time having simpler gate-drive requirements of the familiar power MOSFET. They provide substantial benefits to a host of high-voltage, high-current applications.



**Absolute Maximum Ratings**

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Voltage	900	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	51	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	28	
$I_{CM}$	Pulsed Collector Current ①	100	
$I_{LM}$	Clamped Inductive Load Current ②	100	
$V_{GE}$	Gate-to-Emitter Voltage	$\pm 20$	
$E_{ARV}$	Reverse Voltage Avalanche Energy ③	20	mJ
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	200	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	78	
$T_J$	Operating Junction and Storage Temperature Range	-55 to +150	$^\circ C$
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting torque, 6-32 or M3 screw.	10 lbf•in (1.1N•m)	

**Thermal Resistance**

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	-----	-----	0.64	$^\circ C/W$
$R_{\theta CS}$	Case-to-Sink, flat, greased surface	-----	0.24	-----	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	-----	-----	40	
Wt	Weight	-----	6 (0.21)	-----	g (oz)

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

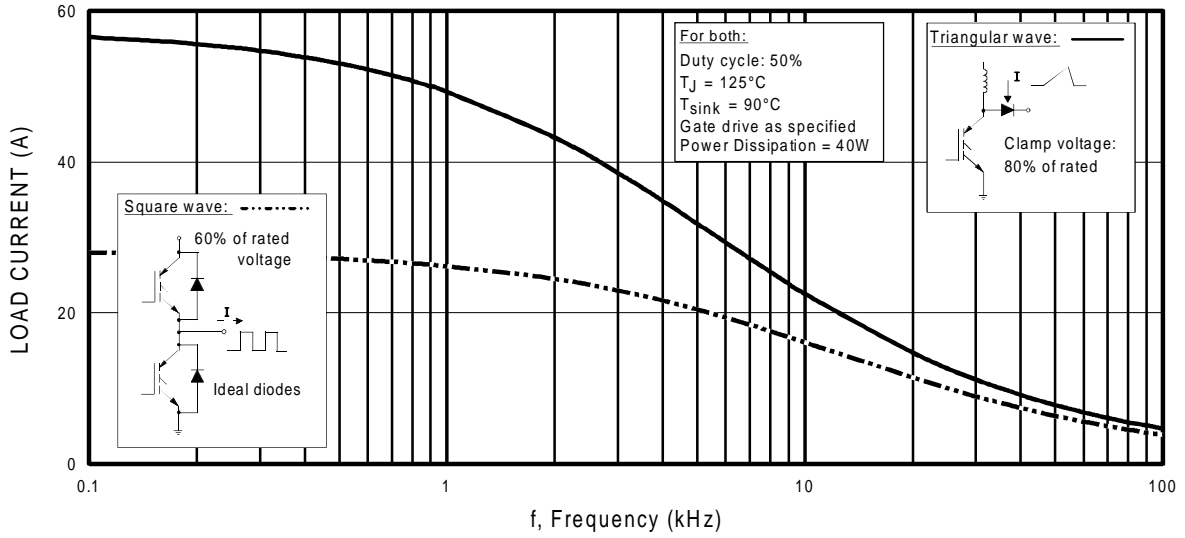
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)CES}$	Collector-to-Emitter Breakdown Voltage	900	----	----	V	$V_{GE} = 0V, I_C = 250\mu\text{A}$
$V_{(BR)ECS}$	Emitter-to-Collector Breakdown Voltage <sup>④</sup>	20	----	----	V	$V_{GE} = 0V, I_C = 1.0A$
$\Delta V_{(BR)CES}/\Delta T_J$	Temperature Coeff. of Breakdown Voltage	----	0.74	----	V/ $^\circ\text{C}$	$V_{GE} = 0V, I_C = 1.0mA$
$V_{CE(on)}$	Collector-to-Emitter Saturation Voltage	----	2.1	2.7	V	$I_C = 28A$
		----	2.7	----		$I_C = 51A$
		----	2.4	----		$I_C = 28A, T_J = 150^\circ\text{C}$
$V_{GE(th)}$	Gate Threshold Voltage	3.0	----	5.5		$V_{CE} = V_{GE}, I_C = 250\mu\text{A}$
$\Delta V_{GE(th)}/\Delta T_J$	Temperature Coeff. of Threshold Voltage	----	-9.7	----	mV/ $^\circ\text{C}$	$V_{CE} = V_{GE}, I_C = 250\mu\text{A}$
$g_{fe}$	Forward Transconductance <sup>⑤</sup>	12	18	----	S	$V_{CE} = 100V, I_C = 28A$
$I_{CES}$	Zero Gate Voltage Collector Current	----	----	250	$\mu\text{A}$	$V_{GE} = 0V, V_{CE} = 900V$
		----	----	2000		$V_{GE} = 0V, V_{CE} = 900V, T_J = 150^\circ\text{C}$
$I_{GES}$	Gate-to-Emitter Leakage Current	----	----	$\pm 100$	nA	$V_{GE} = \pm 20V$

**Switching Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

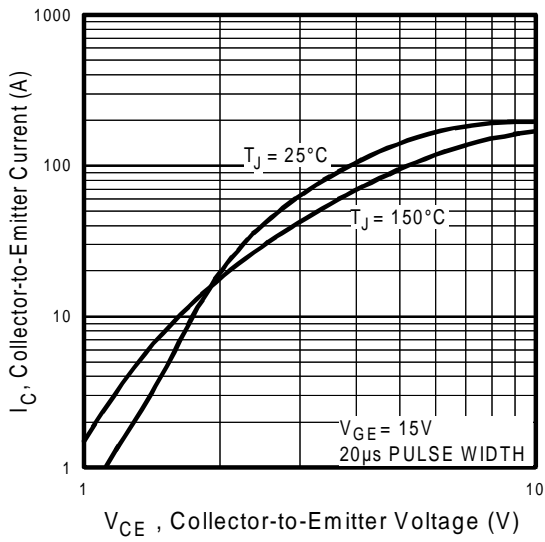
	Parameter	Min.	Typ.	Max.	Units	Conditions
$Q_g$	Total Gate Charge (turn-on)	----	81	120	nC	$I_C = 28A$
$Q_{ge}$	Gate - Emitter Charge (turn-on)	----	16	24		$V_{CC} = 400V$
$Q_{gc}$	Gate - Collector Charge (turn-on)	----	29	44		$V_{GE} = 15V$
$t_{d(on)}$	Turn-On Delay Time	----	32	----	ns	$T_J = 25^\circ\text{C}$
$t_r$	Rise Time	----	22	----		$I_C = 28A, V_{CC} = 720V$
$t_{d(off)}$	Turn-Off Delay Time	----	200	280		$V_{GE} = 15V, R_G = 5.0\Omega$
$t_f$	Fall Time	----	130	180		Energy losses include "tail"
$E_{on}$	Turn-On Switching Loss	----	1.1	----	mJ	See Fig. 9, 10, 11, 14
$E_{off}$	Turn-Off Switching Loss	----	1.8	----		
$E_{ts}$	Total Switching Loss	----	2.9	4.1		
$t_{d(on)}$	Turn-On Delay Time	----	32	----	ns	$T_J = 150^\circ\text{C},$
$t_r$	Rise Time	----	20	----		$I_C = 28A, V_{CC} = 720V$
$t_{d(off)}$	Turn-Off Delay Time	----	480	----		$V_{GE} = 15V, R_G = 5.0\Omega$
$t_f$	Fall Time	----	450	----		Energy losses include "tail"
$E_{ts}$	Total Switching Loss	----	5.7	----	mJ	See Fig. 10, 14
$L_E$	Internal Emitter Inductance	----	13	----	nH	Measured 5mm from package
$C_{ies}$	Input Capacitance	----	2300	----	pF	$V_{GE} = 0V$
$C_{oes}$	Output Capacitance	----	180	----		$V_{CC} = 30V$
$C_{res}$	Reverse Transfer Capacitance	----	27	----		$f = 1.0MHz$

**Notes:**

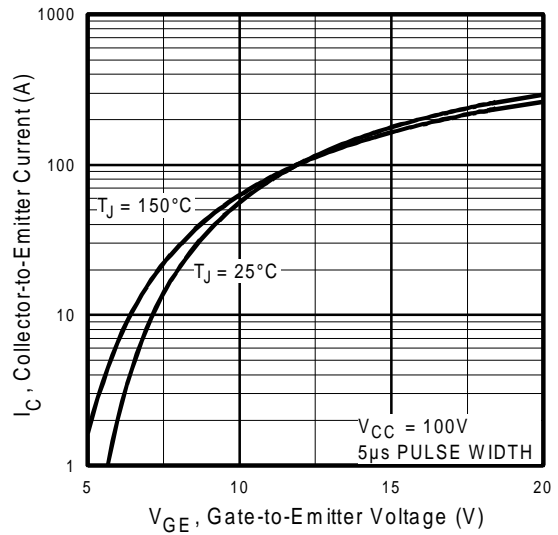
- ① Repetitive rating;  $V_{GE}=20V$ , pulse width limited by max. junction temperature. ( See fig. 13b )
- ②  $V_{CC}=80\%(V_{CES}), V_{GE}=20V, L=10\mu\text{H}, R_G=5.0\Omega$ , ( See fig. 13a )
- ③ Repetitive rating; pulse width limited by maximum junction temperature.
- ④ Pulse width  $\leq 80\mu\text{s}$ ; duty factor  $\leq 0.1\%$ .
- ⑤ Pulse width  $5.0\mu\text{s}$ , single shot.



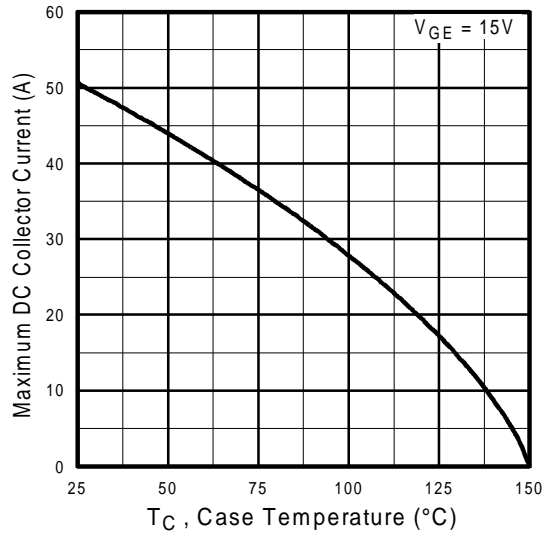
**Fig. 1 - Typical Load Current vs. Frequency**  
 (For square wave,  $I = I_{RMS}$  of fundamental; for triangular wave,  $I = I_{PK}$ )



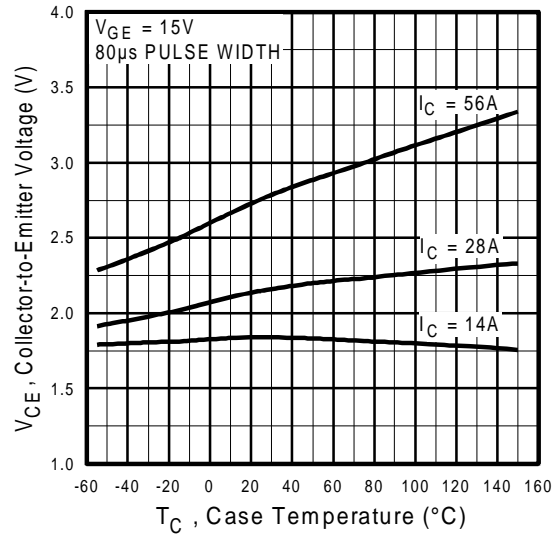
**Fig. 2 - Typical Output Characteristics**



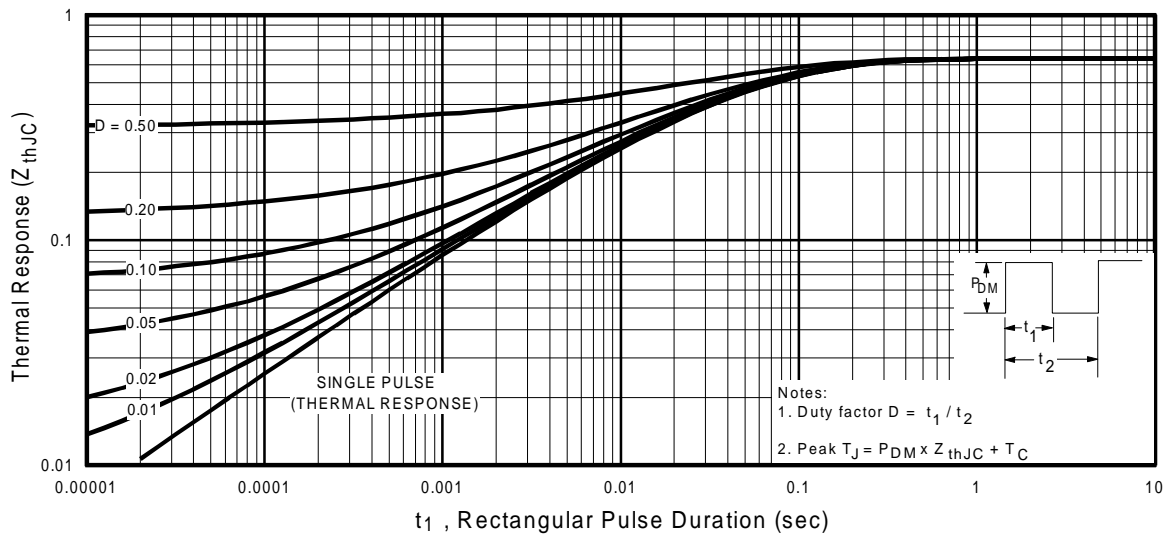
**Fig. 3 - Typical Transfer Characteristics**



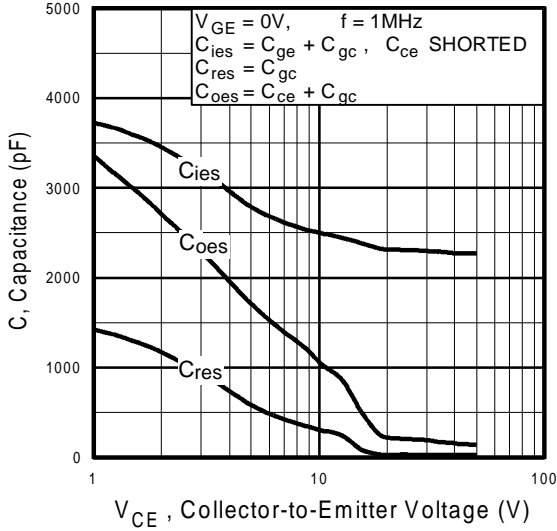
**Fig. 4 - Maximum Collector Current vs. Case Temperature**



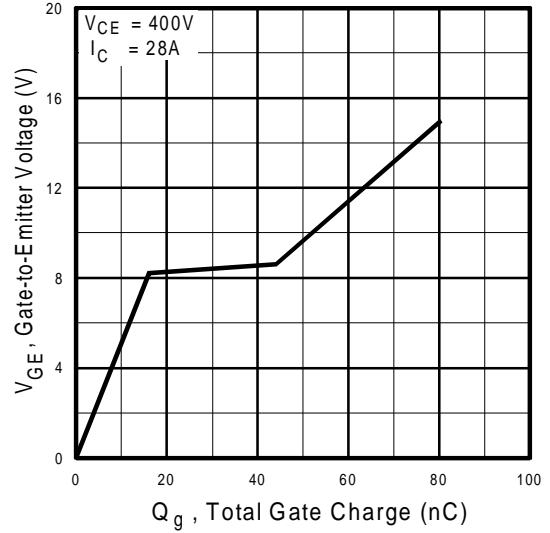
**Fig. 5 - Collector-to-Emitter Voltage vs. Case Temperature**



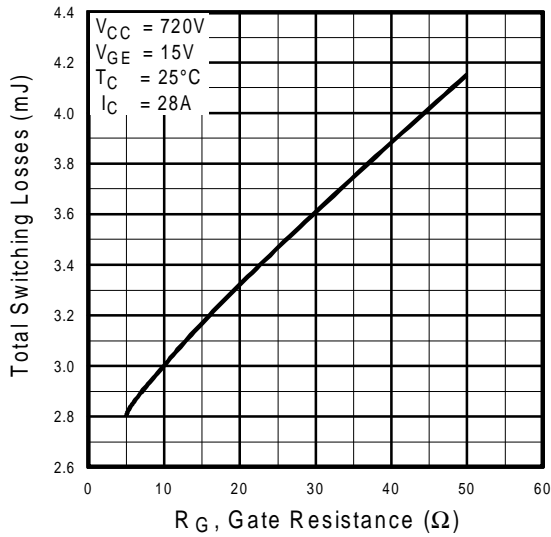
**Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**



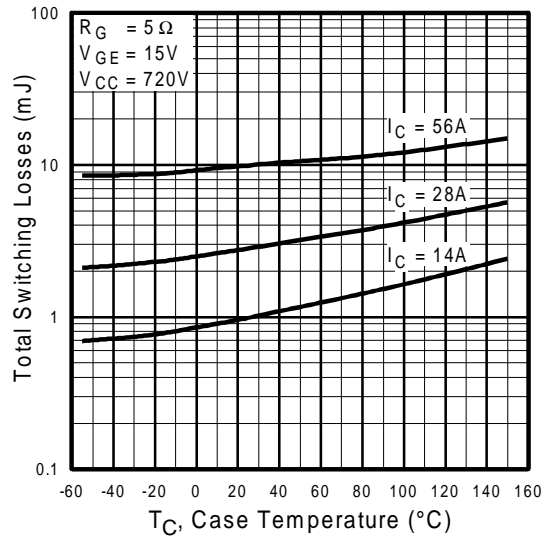
**Fig. 7** - Typical Capacitance vs. Collector-to-Emitter Voltage



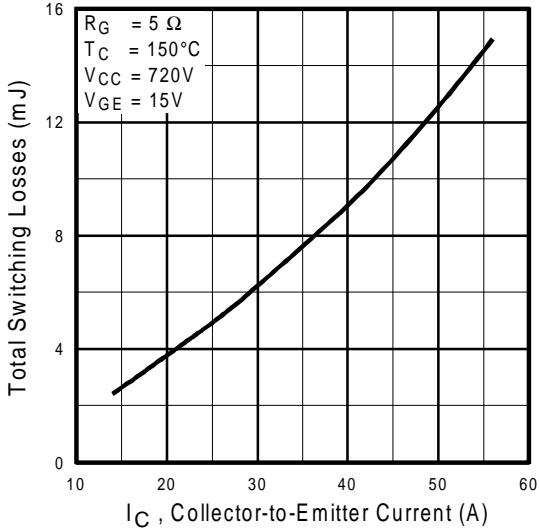
**Fig. 8** - Typical Gate Charge vs. Gate-to-Emitter Voltage



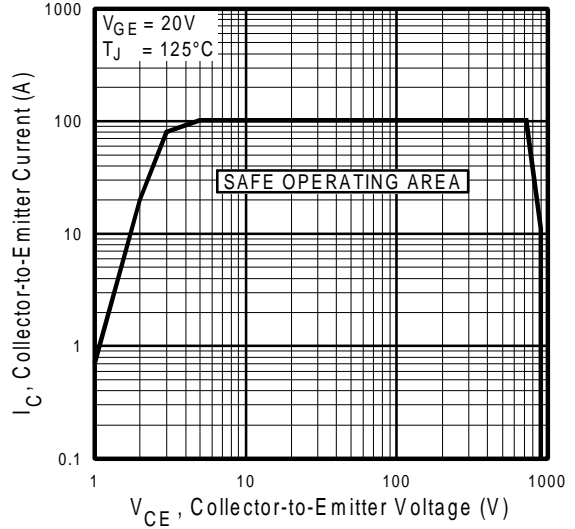
**Fig. 9** - Typical Switching Losses vs. Gate Resistance



**Fig. 10** - Typical Switching Losses vs. Case Temperature



**Fig. 11** - Typical Switching Losses vs. Collector-to-Emitter Current



**Fig. 12** - Turn-Off SOA

Refer to **Section D** for the following:

**Appendix F: Section D - page D-8**

- Fig. 13a - Clamped Inductive Load Test Circuit
- Fig. 13b - Pulsed Collector Current Test Circuit
- Fig. 14a - Switching Loss Test Circuit
- Fig. 14b - Switching Loss Waveform

**Package Outline 3 - JEDEC Outline TO-247AC (TO-3P) Section D - page D-13**